<b>Notes</b>



Application/Control No.

Applicant(s)/Patent under Reexamination

10/655,098

KAWAHARA ET AL.

Examiner

Art Unit

2817

Stephen E. Jones

SEARCHED					
Class	Subclass	Date	Examiner		
333	204,134, 185,219	12/1/2005	SJ		
wp.	lated	5/28/06	81		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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